

Notice of References Cited	Application/Control No. 10/602,740	Applicant(s)/Patent Under Reexamination FUJIYAMA ET AL.	
	Examiner Quan Tra	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,736,885	04-1998	Wietecha et al.	327/307
	B	US-5,365,191	11-1994	Hayashi, Shigeyoshi	330/252
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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